## Issue Classification

Application/Control No. 10/709,278

Applicant(s)/Patent under Reexamination LIEN ET AL.

**Examiner Kyoung Lee** 

**Art Unit** 

		A		ISSUE	CL	<u>.AS</u>	SIF	ICAT	ION			
ORIGINAL						INTERNATIONAL CLASSIFICATION						
CLASS 438			SUBCLASS 623		CLAIMED					NON-CLAIMED		
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	CROS	S REFEREN	ICES									
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										, i	
438	694	625	626	627					1		1	
438	629	631	634	636					1		1	
438	637	638			0				1		1	
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Kyoung Lee 6/29/2006 (Date) (Assistant Examiner)

ients Examiner)

MICHAEL LEBENTRITT

**Total Claims Allowed: 11** 

SUPERVISORY PATENT EXAMINER (Primary Examiner)

0.G. Print Claim(s)

O.G. Print Fig.

□ СРА ☐ R.1.47 ☐ T.D. Claims renumbered in the same order as presented by applicant Original Original Original Original Original Original Original Final Final Final Final Final